## Notice of References Cited Application/Control No. 09/661,930 Examiner Kim Nguyen Applicant(s)/Patent Under Reexamination STEPHAN, DON Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,270,410 B1	08-2001	DeMar et al.	463/20
	В	US-5,926,153 A	07-1999	Ohishi et al.	345/1.1
	C	US-6,290,603 B1	09-2001	Luciano, Jr., Robert A.	463/25
	D	US-6,283,862 B1	09-2001	Richter, Wolfgang	463/51
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	j	US-			,
-	K	US-			
	L	US-			
	M	US-			

## FOREIGN PATENT DOCUMENTS

	•						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
	0						
	Р						
	Q						
	R						
	S						
	Т	·					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.